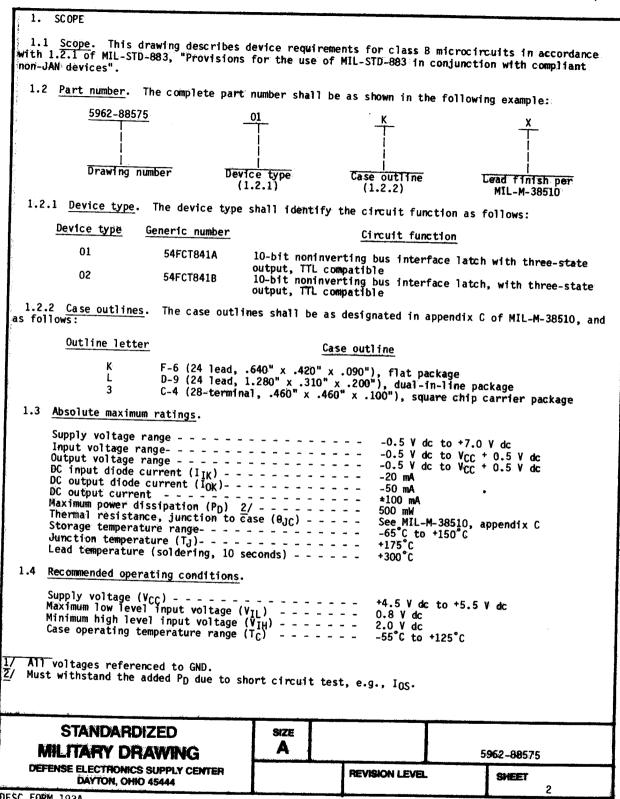
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	DRAWING THIS DRAWING IS AVAILABLE			Ī	MICROCIRCUITS, DIGITAL, FAST CMOS, 10-NONINVERTING BUS INTERFACE LATCH WITH						Н	Т													
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DISTRIBUTION STATEMENT A. Approved for public release; distribution is unlimited.

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Minimum setup time, Dn to LE, (t_S):

Device type 01 - - - - - - - - - 2.5 ns
Device type 02 - - - - - - - - 2.5 ns

Minimum hold time, Dn to LE, (t_h):

Device type 01 - - - - - - - - - 2.5 ns

Minimum pulse width, LE, (t_w):

Device type 01 - - - - - - - - 6.0 ns
Device type 02 - - - - - - - - - - 4.0 ns

2. APPLICABLE DOCUMENTS

2.1 Government specification, standard, and bulletin. Unless otherwise specified, the following specification, standard, and bulletin of the issue listed in that issue of the Department of Defense Index of Specifications and Standards specified in the solicitation, form a part of this drawing to the extent specified herein.

SPECIFICATION

MIL ITARY

MIL-M-38510 - Microcircuits, General Specification for.

STANDARD

MILITARY

MIL-STD-883 - Test Methods and Procedures for Microelectronics.

BULLETIN

MILITARY

MIL-BUL-103 - List of Standardized Military Drawings (SMD's).

(Copies of the specification, standard, and bulletin required by manufacturers in connection with specific acquisition functions should be obtained from the contracting activity or as directed by the contracting activity.)

- 2.2 Order of precedence. In the event of a conflict between the text of this drawing and the references cited herein, the text of this drawing shall take precedence.
 - REQUIREMENTS
- 3.1 Item requirements. The individual item requirements shall be in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices" and as specified herein.
- 3.2 <u>Design, construction, and physical dimensions</u>. The design, construction, and physical dimensions shall be as specified in MIL-M-38510 and herein.
 - 3.2.1 Terminal connections. The terminal connections shall be as specified on figure 1.
 - 3.2.2 Truth table. The truth table shall be as specified on figure 2.
 - 3.2.3 Logic diagram. The logic diagram shall be as specified on figure 3.
 - 3.2.4 <u>Case outlines</u>. The case outlines shall be in accordance with 1.2.2 herein.

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TABLE I. Electrical performance characteristics. Test Symbol I Conditions Device Group: A Limits Unit -55°C < TC < +125°C V_{CC} = 5.0 V dc ±10% unless otherwise specified type |subgroups| Min Max VCC = 4.5 V, VIL = 0.8 V, 1, 2, 3 High level output I VOH IIOH = -300 μA A11 ٧., 4.3 voltage VIH = 2.0 V $I_{OH} = -15 \text{ mA}$ A11 1, 2, 3 2.4 Low level output | VCC = 4.5 V. I_{OL} = 300 μA VOL. A11 1, 2, 3 0.2 ٧٧ |VIL = 0.8 V, voltage IVIH = 2.0 V IOL = 32 mA A11 1, 2, 3 0.5 Input clamp voltage $V_{CC} = 4.5^{\circ} V$, $I_{IN} = -18^{\circ} mA$ A11 1, 2, 3 ٧ VIK -1.2 High level input $V_{CC} = 5.5 \text{ V}, V_{IN} = 5.5 \text{ V}$ **A11** 1, 2, 3 $|I_{IH}|$ 5.0 μΑ current Low level input $V_{CC} = 5.5 \text{ V}, V_{IN} = GND$ IIL A11 1, 2, 3 -5.0 μΑ current High impedence output $|V_{CC} = 5.5 \text{ V}, V_{IN} = 5.5 \text{ V}$ IOZH A11 1, 2, 3 10 μА current IOZL. VCC = 5.5 V, VIN = GND **A11** 1, 2, 3 -10 $\mu A^{\hat{}}$ VCC = 5.5 V VO = GND Short circuit output IOS 1/ 1, 2, 3 | -75 A11 mΑ current $\begin{array}{l} |V_{IN}| \leq 0.2 |V| \text{ or } |V_{IN}| \geq 5.3 |V|, \\ |V_{CC}| = 5.5 |V|, \quad f_{I} = 0. \text{ MHz} \end{array}$ Quiescent power supply I CCO A11 1, 2, 3 1.5 mΑ current (CMOS inputs) Quiescent power supply | AICC current (TTL inputs) | $V_{CC} = 5.5 \text{ V}, V_{IN} = 3.4 \text{ V } 2/$ A11 1, 2, 3 mΑ 2.0 V_{CC} = 5.5 V, OE = GNB, |One bit toggling, 50% duty cycle, |V_{IN} > 5.3 V or V_{IN} < 0.2 V |Outputs open, LE = V_{CC} Dynamic power supply A11 ICCD 3/ 0.25 mA/ current MHz See footnotes at end of table. SIZE STANDARDIZED A 5962-88575 MILITARY DRAWING DEFENSE ELECTRONICS SUPPLY CENTER REVISION LEVEL **SHEET** DAYTON GHIO 4544

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TABLE I. Electrical performance characteristics - Continued.								
Test	Symbol	Condition -55°C < TC ≤	Device	Group A	Lin	 Unit		
		V _{CC} = 5.0 V unless otherwis	dc ±10%	type	subgroups 	 Min 	Max	T !
Total power supply current	ICC	V _{CC} = 5.5 V, loutputs open, f _I = 10 MHz, 50% duty cycle,	V _{IN} ≥ 5.3 V or V _{IN} < 0.2 V	 A11 	 1, 2, 3 		4.0	l mA
	 	One bit toggling, OE = GND, LE = VCC 4/	V _{IN} = 3.4 V or V _{IN} = GND	A11 	1, 2, 3		5.0	l mA
Input capacitance	of Capacitance CIN See 4.3.1c				4		10	pF
Output capacitance	utput capacitance COUT See 4.3.1c			IA11	4		1 12	pF
Functional tests	l	See 4.3.1d		 A11	7, 8			
Propagation delay time Dn to Yn	l tp _{LH1,} t _{PHL1}	R _I = 500Ω.		T	9, 10, 11	1.5	10.0	ns
(LE = high)		See figure 4		02		1.5	7.5	
Propagation delay time LE to Yn	tPLH2, tPHL2	≅ ′		01	9, 10, 11	1.5	13.0	ns
	1 1162	-	_	02	! i	1.5	10.5	
Output enable time, OE 🗲 to Yn	t _{PZH} , t _{PZL}		-	01	9, 10, 11	1.5	13.0	ns
	<u> </u>		-	i 02		1.5	8.5	
	tpHZ, tpLZ		-	01	9, 10, 11	1.5	10.0	ns
				02	i	1.5	7.5	

Not more than one output should be shorted at one time, and the duration of the short circuit condition should not exceed 1 second. $\,$

 $^{D}_{H}$ = Duty cycle for TTL inputs high $^{N}_{T}$ = Number of TTL inputs at $^{D}_{H}$ f $_{I}$ = Input frequency in MHZ $^{N}_{I}$ = Number of inputs at f $_{I}$

 $\underline{5}/$ The minimum limits are guaranteed, if not tested, to the limits specified in table I.

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²/ TTL driven input (V $_{
m IN}$ = 3.4 V); all other inputs at V $_{
m CC}$ or GND.

 $[\]underline{3}$ / This parameter is not directly testable, but is derived for use in total power supply calculations.

 $[\]frac{4}{I_{CC}} = I_{CCQ} + (\Delta I_{CC} \times D_H \times N_T) + (I_{CCD} \times f_I \times N_I)$ where:

Device types 01 and 02 Case outline E, F 2 Terminal Terminal symbol number Œ NC OE DO 00 D1 D2 D3 D1 D2 D3 D4 NC D4 D5 . 8 9 D6 D7 D5 10 11 12 13 14 15 16 17 18 19 20 21 22 23 24 25 26 27 D8 D6 D9 D7 GND **D8** LE Y9 D9 GND NC LE Y9 Y8 Y7 Y6 Y5 NC Y4 Y3 Y2 Ý8 Y7 Y6 Y5 Y4 Y3 Y2 Y1 Y0 **VCC Y1** YO 28 VCC

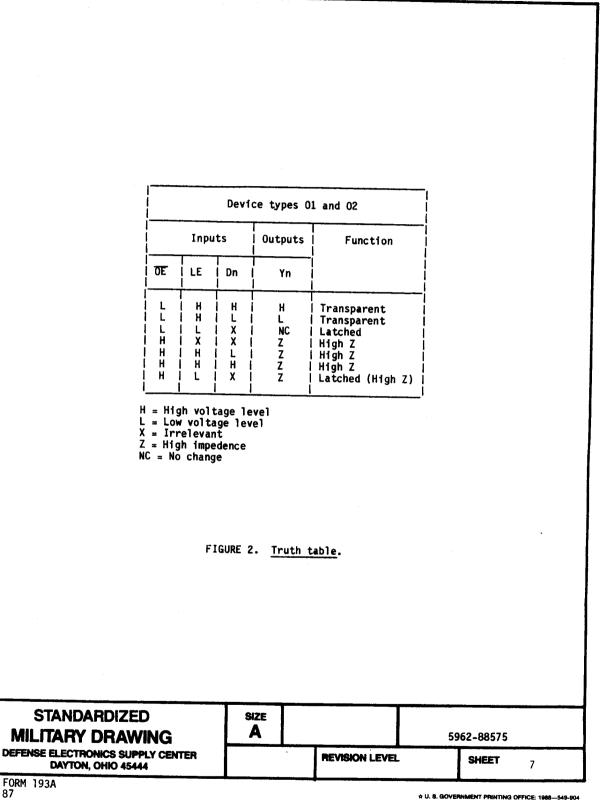
FIGURE 1. Terminal connections.

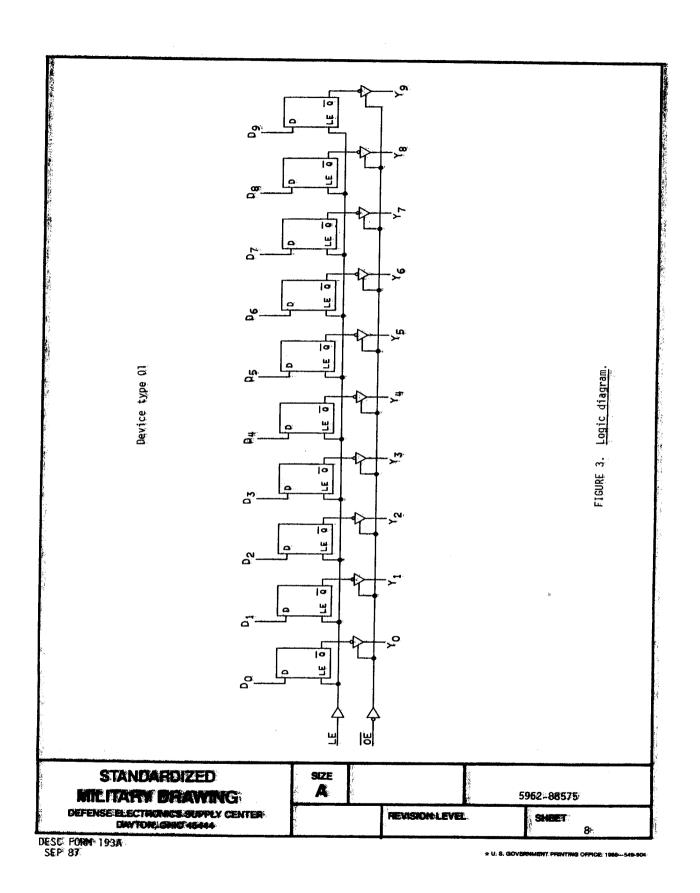
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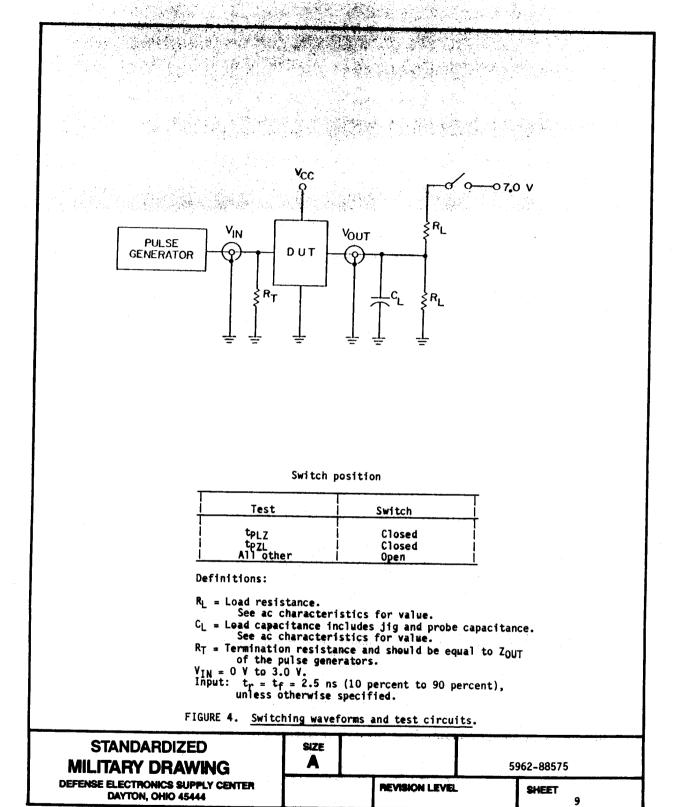
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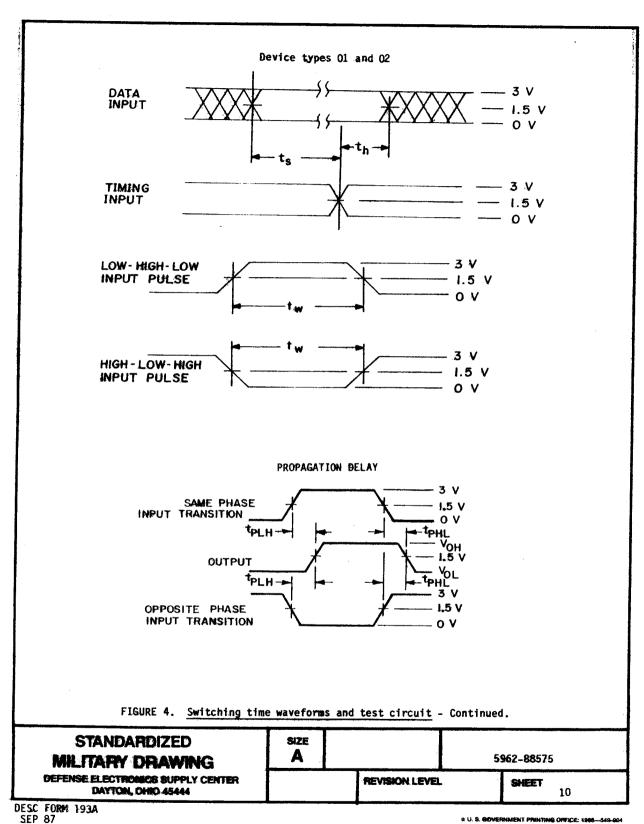
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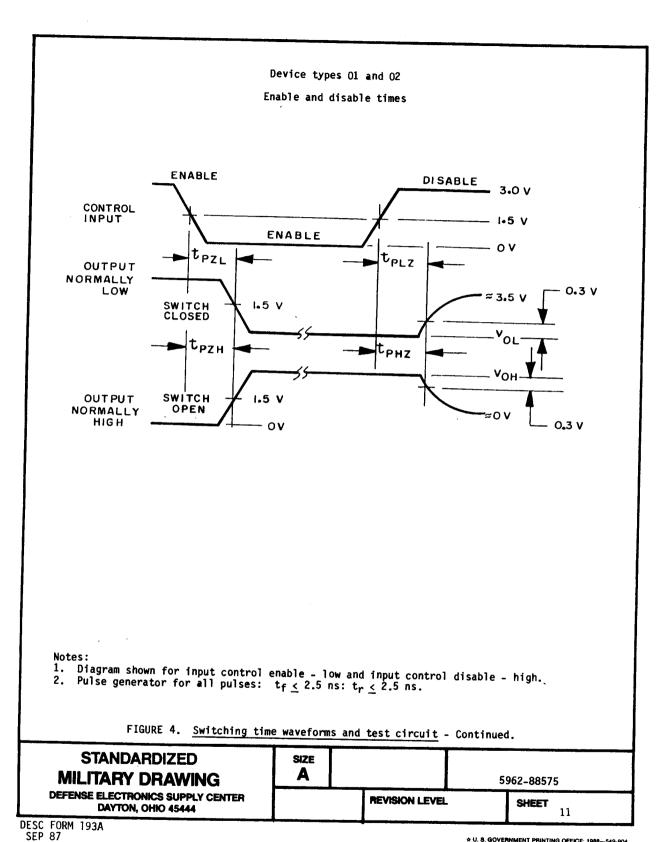






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- 3.3 Electrical performance characteristics. Unless otherwise specified herein, the electrical performance characteristics are as specified in table I and apply over the full case operating temperature range.
- 3.4 Electrical test requirements. The electrical test requirements shall be the subgroups specified in table II. The electrical tests for each subgroup are described in table I.
- 3.5 Marking. Marking shall be in accordance with MIL-STD-883 (see 3.1 herein). The part shall be marked with the part number listed in 1.2 herein. In addition, the manufacturer's part number may also be marked as listed in MIL-BUL-103 (see 6.6 herein).
- 3.6 Certificate of compliance. A certificate of compliance shall be required from a manufacturer in order to be listed as an approved source of supply in MIL-BUL-103 (see 6.6 herein). The certificate of compliance submitted to DESC-ECS prior to listing as an approved source of supply shall affirm that the manufacturer's product meets the requirements of MIL-STD-883 (see 3.1 herein) and the requirements herein.
- 3.7 Certificate of conformance. A certificate of conformance as required in MIL-STD-883 (see 3.1 herein) shall be provided with each lot of microcircuits delivered to this drawing.
- 3.8 Notification of change. Notification of change to DESC-ECS shall be required in accordance with MIL-STD-883 (see 3.1 herein).
- 3.9 <u>Verification and review</u>. DESC, DESC's agent, and the acquiring activity retain the option to review the manufacturer's facility and applicable required documentation. Offshore documentation shall be made available onshore at the option of the reviewer.
 - 4. QUALITY ASSURANCE PROVISIONS
- 4.1 Sampling and inspection. Sampling and inspection procedures shall be in accordance with section $\frac{4}{4}$ of MIL-M-38510 to the extent specified in MIL-STD-883 (see 3.1 herein).
- 4.2 <u>Screening</u>. Screening shall be in accordance with method 5004 of MIL-STD-883, and shall be conducted on all devices prior to quality conformance inspection. The following additional criteria shall apply:
 - a. Burn-in test, method 1015 of MIL-STD-883.
 - Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.6 herein).
 - (2) $T_A = +125^{\circ}C$, minimum.
 - b. Interim and final electrical test parameters shall be as specified in table II herein, except interim electrical parameter tests prior to burn-in are optional at the discretion of the manufacturer.
- 4.3 Quality conformance inspection. Quality conformance inspection shall be in accordance with method 5005 of MIL-STD-883 including groups A, B, C, and D inspections. The following additional criteria shall apply.
 - 4.3.1 Group A inspection.
 - Tests shall be as specified in table II herein.
 - b. Subgroups 5 and 6 in table I, method 5005 of MIL-STD-883 shall be omitted.

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- c. Subgroup 4 ($C_{ ext{IN}}$ and $C_{ ext{OUT}}$ measurements) shall be measured only initially and after process or design changes which may affect capacitance. Test all applicable pins on 5 devices with zero failures.
- d. Subgroups 7 and 8 tests shall verify the truth table as specified on figure 2.

4.3.2 Groups C and D inspections.

- a. End-point electrical parameters shall be as specified in table II herein.
- Steady-state life test conditions, method 1005 of MIL-STD-883.
 - (1) Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.6 herein).
 - (2) $T_A = +125^{\circ}C$, minimum.
 - (3) Test duration: 1,000 hours, except as permitted by method 1005 of MIL-STD-883.

TABLE II. Electrical test requirements.

T	· ·
MIL-STD-883 test requirements	Subgroups Subgroups Oper method 5005, table I)
Interim electrical parameters (method 5004)	
Final electrical test parameters (method 5004)	1*, 2, 3, 7 8, 9, 10, 11
Group A test requirements (method 5005)	1, 2, 3, 4, 7, 8, 9, 10, 11
Groups C and D end-point electrical parameters (method 5005)	1, 2, 3

^{*} PDA applies to subgroup 1.

- 5. PACKAGING
- 5.1 Packaging requirements. The requirements for packaging shall be in accordance with MIL-M-38510.
 - 6. NOTES
- 6.1 Intended use. Microcircuits conforming to this drawing are intended for use when military specifications do not exist and qualified military devices that will perform the required function are not available for OEM application. When a military specification exists and the product covered by this drawing has been qualified for listing on QPL-38510, the device specified herein will be inactivated and will not be used for new design. The QPL-38510 product shall be the preferred item
- 6.2 Replaceability. Microcircuits covered by this drawing will replace the same generic device covered by a contractor-prepared specification or drawing.

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- 6.3 Comfiguration control of SMD's. All proposed changes to existing SMD's will be coordinated with the users of record for the individual documents. This coordination will be accomplished in accordance with MIL-STD-481 using DD Form 1693, Engineering Change Proposal (Short Form).
- 6.4 Record of users. Military and industry users shall inform Defense Electronics Supply Center when a system application requires configuration control and the applicable SMD. DESC will maintain a record of users and this list will be used for coordination and distribution of changes to the drawings. Users of the drawing covering microelectronics devices (FSC 5962) should contact DESC-ECS, telephone (513)296-6022.
- 6.5 Comments. Comments on this drawing should be directed to DESC-ECS, Dayton, Ohio 45444, or telephone (513) 296-5375.
- 6.6 Approved sources of supply. Approved sources of supply are listed in MIL-BUL-103. Additional sources will be added to MIL-BUL-103 as they become available. The vendors listed in MIL-BUL-103 have agreed to this drawing and a certificate of compliance (see 3.6 herein) has been submitted to and accepted by DESC-ECS. The approved source of supply listed below is for information purposes only and is current only to the date of the last action of this document.

 Military drawing part number	Vendor CAGE number	Vendor similar part number <u>1</u> /
 5962-8857501KX 	61772	IDT54FCT841AEB
 5962-8857501LX 	61772 97527	IDT54FCT841ADB VJ54FCT841AD
5962-88575013X	61772 92527	
 5962-8857502KX 	 61772 	IDT54FCT841BEB
 5962-8857502LX 	61772	IDT54FCT841BDB
5962-88575023X	61772	IDT54FCT841BLB

1/ Caution. Do not use this number for item acquisition. Items acquired to this number may not satisfy the performance requirements of this drawing.

Vendor CAGE Vendor name number and address 61772 Integrated Device Technology 3236 Scott Boulevard Santa Clara, CA 95052 9Z527 VTC Incorporated 2401 East 86th Street Bloomington, MN 55420

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